ecoSwitch™ Advanced Load Management

Controlled Load Switch with Ultra Low RON

NCP45770

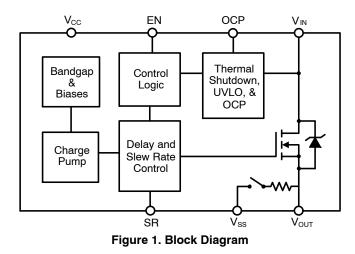
The NCP45770 load management device provides a component and area-reducing solution for efficient power domain switching with inrush current limit via soft start. These devices are designed to integrate control and driver functionality with a high performance ultra-low on-resistance power MOSFET in a single package offering safeguards and monitoring via fault protection and power good signaling. This cost effective solution is ideal for power management and disconnect functions in USB Type-C ports and power management applications requiring low power consumption in a small footprint.

Features

- Advanced Controller with Charge Pump
- Integrated N-Channel MOSFET with Ultra-Low RON
- Soft-Start via Controlled Slew Rate
- Adjustable Slew Rate Control
- Fault Detection with Power Good Output
- Thermal Shutdown and Under Voltage Lockout
- Short-Circuit and Adjustable Over-Current Protections
- Input Voltage Range 3 V to 24 V
- Extremely Low Standby Current
- This is a RoHS/REACH Compliant Device

Typical Applications

- USB Type C Power Delivery
- Servers, Set-Top Boxes and Gateways
- Notebook and Tablet Computers
- Telecom, Networking, Medical and Industrial Equipment
- Hot-Swap Devices and Peripheral Ports



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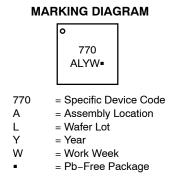
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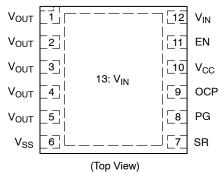
R _{ON} TYP	V _{IN}	*DC I _{MAX}
$3.6~\mathrm{m}\Omega$	3 V to 24 V	20 A

*I_{MAX} is defined as the maximum steady state current the load switch can pass at room ambient temperature without entering thermal lockout. See the SOA section for more information on transient current limitations.





PIN CONFIGURATION



ORDERING INFORMATION

Device	Package	Shipping
NCP45770IMN24TWG	DFN12 (RoHS/ REACH)	3000 / Tape & Reel

Table 1. PIN DESCRIPTION

Pin	Name	Function
1,2,3,4,5	V _{OUT}	Source of MOSFET connected to load. Includes an internal bleed resistor to GND. – All pins must be con- nected to provide correct Rds, OCP, and current capability.
6	V _{SS}	Driver ground
7	SR	Slew Rate control pin. Slew rate adjustment made with an external capacitor to GND; float if not used.
8	PG	Active-high, open-drain output that indicates when the gate of the MOSFET is fully charged, external pull up resistor $\ge 100 \text{ k}\Omega$ to an external voltage source required; tie to GND if not used.
9	OCP	Over-current protection trip point adjustment is made with a resistor to ground. Connect OCP directly to ground it over current protection is not needed.
10	V _{CC}	Driver supply voltage (3.0 V – 5.5 V)
11	EN	Active-high digital input used to turn on the MOSFET driver, pin has an internal pull down resistor to GND.
12,13	V _{IN}	Input voltage (3 V – 24 V) – Pin 13 should be used for high current (>0.5 A)

Table 2. ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Supply Voltage Range	V _{CC}	–0.3 to 6	V
Input Voltage Range	V _{IN}	–0.3 to 30	V
Output Voltage Range	V _{OUT}	-0.3 to 30	V
EN Input Voltage Range	V _{EN}	–0.3 to 6	V
PG Output Voltage Range (Note 1)	V _{PG}	–0.3 to 6	V
OCP Input Voltage Range	V _{OCP}	–0.3 to 6	V
Thermal Resistance, Junction-to-Ambient, Steady State (Note 2)	R _{θJA}	49.7	°C/W
Thermal Resistance, Junction-to-Case (VIN Paddle)	R _{θJC}	1.7	°C/W
Continuous MOSFET Current @ T _A = 25°C (Note 2)	I _{MAX}	20	А
Storage Temperature Range	T _{STG}	-55 to 150	°C
Lead Temperature, Soldering (10 sec.)	T _{SLD}	260	°C
ESD Capability, Human Body Model (Notes 3 and 4)	ESD _{HBM}	2	kV
ESD Capability, Charged Device Model (Notes 3 and 4)	ESD _{CDM}	0.5	kV
Latch-up Current Immunity (Note 3)	LU	100	mA

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. PG is an open drain output that requires an external pull-up resistor > 100 k Ω to an external voltage source.

2. Surface-mounted on FR4 board using the minimum recommended pad size, 1 oz Cu. Over current protection will limit maximum realized current to 20 A at highest setting.
 Tested by the following methods @ T_A = 25°C:

ESD Human Body Model tested per JS-001 ESD Charged Device Model per ESD JS-002

Latch-up Current tested per JESD78

PG, OCP, and SR pins must be connected correctly for compliance.
4. Rating is for all pins except for V_{IN} and V_{OUT} which are tied to the internal MOSFET's Drain and Source. Typical MOSFET ESD performance for V_{IN} and V_{OUT} should be expected and these devices should be treated as ESD sensitive.

Table 3. OPERATING RANGES

Rating	Symbol	Min	Max	Unit
VCC – (V _{IN} > 4.5 V)	V _{CC}	3	5.5	V
$VCC - (V_{IN} < 4.5 V)$	V _{CC}	4.5	5.5	V
$VIN - (V_{CC} > 4.5 V)$	V _{IN}	3	24	V
$VIN - (V_{CC} < 4.5 V)$	V _{IN}	4.5	24	V
OCP External Resistor to VSS	R _{OCP}	short	open	kΩ
OFF to ON Transition Energy Dissipation Limit (See application section)	E _{TRANS}		220	mJ

Table 3. OPERATING RANGES

Rating	Symbol	Min	Max	Unit
VSS	V _{SS}		0	V
Ambient Temperature	T _A	-40	85	°C
Junction Temperature	TJ	-40	125	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

Table 4. ELECTRICAL CHAP	RACTERISTICS (T _J = 25°C, V _{CC} = 3 V – 5.5 V, unless	s otherwise specified)
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Parameter	Conditions	Symbol	Min	Тур	Max	Unit
On-Resistance	$V_{CC} = 4.5 \text{ V}; \text{ V}_{IN} = 3 \text{ V}$	R _{ON}		3.6	4.2	mΩ
	$V_{CC} = 3.3 \text{ V}; \text{ V}_{IN} = 4.5 \text{ V}$			3.6	4.2	
	$V_{CC} = 3.3 \text{ V}; \text{ V}_{IN} = 15 \text{ V}$			3.6	4.2	
	$V_{CC} = 3.3 \text{ V}; \text{ V}_{IN} = 24 \text{ V}$			3.6	4.2	
Leakage Current – V_{IN} to V_{OUT} (Note 5)	V _{EN} = 0 V; V _{IN} = 24 V	I _{LEAK}		22.8	100	nA
V_{IN} Control Current – V_{IN} to V_{SS}	$V_{EN} = 0 \text{ V}; \text{ V}_{IN} = 24 \text{ V} \text{ (for typical)}$	I _{INCTL}		0.805	1.5	μA
V_{IN} Control Current – V_{IN} to V_{SS}	$V_{EN} = V_{CC}$; $V_{IN} = 24 V$ (for typical)	I _{INCTL_EN}		143	300	μA
Supply Standby Current (Note 6)	$V_{EN} = 0 \text{ V}; \text{ V}_{IN} = 24 \text{ V} \text{ (for typical)}$	I _{STBY}		1.56	5.0	μA
Supply Dynamic Current (Note 7)	$V_{EN} = V_{CC}$; $V_{IN} = 24 V$ (for typical)	I _{DYN}		0.35	0.5	mA
Bleed Resistance		R _{BLEED}	75	101	200	kΩ
EN Input High Voltage		V _{IH}	2			V
EN Input Low Voltage		V _{IL}			0.8	V
EN Input Leakage Current	V _{EN} = 0 V	IIL	-1.0	0.02	1	μA
EN Pull Down Resistance		R _{PD}	76	100	124	kΩ
PG Output Low Voltage	I _{SINK} = 100 μA	V _{OL}		0.022	0.1	V
PG Output Leakage Current	V _{TERM} = 3.3 V	I _{OH}		3.3	100	nA
Slew Rate Control Constant (Note 8)		K _{SR}	70	109	130	μA
FAULT PROTECTIONS	·	•		•	-	-
Thermal Shutdown Threshold (Note 9)		T _{SDT}		145		°C
Thermal Shutdown Hysteresis (Note 9)		Tuve		20		°C

Thermal Shutdown Threshold (Note 9)		I SDT		145		Ű
Thermal Shutdown Hysteresis (Note 9)		T _{HYS}		20		°C
VIN Under Voltage Lockout Threshold	V _{IN} rising	V _{UVLO}	1.8	2.04	2.3	V
VIN Under Voltage Lockout Hysteresis		V _{HYS}	150	227	300	mV
Over-Current Protection Trip	R _{OCP} = open	I _{TRIP}	1.9	2.9	3.4	А
(V _{CC} = 3.3 V)	R _{OCP} = 100 kΩ			9.3		
	R_{OCP} = 20 k Ω			16.2		
	$R_{OCP} = 1 \ k\Omega$ (Note 10)			20		
	R _{OCP} = short to GND (Note 10)			20		
Over-Current Protection Blanking Time		t _{OCP}		2.25		ms
Short-Circuit Protection Trip Current	$T_{\rm J} = -40^{\circ} C$	I _{SC}		35		А
(Note 11)	$T_J = 150^{\circ}C$			20		
	T _A = 25°C, DC Current (Note 12)			20		

5. Average current from V_{IN} to V_{OUT} with MOSFET turned off. 6. Average current from V_{CC} to GND with MOSFET turned off.

7. Average current from V_{CC} to GND after charge up time of MOSFET. 8. See Applications Information section for details on how to adjust the gate slew rate.

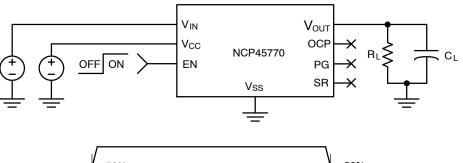
9. Operation above $T_J = 125^{\circ}C$ is not guaranteed. 10. Transient currents exceeding the short-circuit protection trip current will cause the device to fault. For OCP settings less than 20 k Ω , high steady state currents may cause an over temperature lockout before the OCP threshold is reached due to self-heating.

11. Short Circuit Protection protects the device against hard shorts ($R_{SHORT} \le 250 \text{ m}\Omega$ Vout to Ground) for Vin < 18 V, and against soft shorts ($R_{SHORT} > 250 \text{ m}\Omega$) for Vin < 24 V. Short circuit protection testing assumed a 100 W supply capability limit on Vin.

12. A sustained current of more then 20 A may cause a SCP trip or thermal lockout due to self-heating.

Parameter	Conditions	Symbol	Min	Тур	Max	Unit
Output Slew Rate - Default	$V_{CC} = 4.5 \text{ V}; \text{ V}_{IN} = 3 \text{ V}$	SR	13	20.3	28	V/ms
	V _{CC} = 5.0 V; V _{IN} = 3 V		13	20.6	28	1
	V _{CC} = 3.3 V; V _{IN} = 24 V		13	23	28	
	$V_{CC} = 5.0 \text{ V}; \text{ V}_{IN} = 24 \text{ V}$		13	23	28	
Output Turn-on Delay	V_{CC} = 4.5 V; V_{IN} = 3 V	T _{ON}	100	162	700	μs
	$V_{CC} = 5.0 \text{ V}; \text{ V}_{IN} = 3 \text{ V}$		100	161	700	
	$V_{CC} = 3.3 \text{ V}; \text{ V}_{IN} = 24 \text{ V}$		100	446	700	
	$V_{CC} = 5.0 \text{ V}; \text{ V}_{IN} = 24 \text{ V}$		100	443	700	
Output Turn-off Delay	V_{CC} = 4.5 V; V_{IN} = 3 V	T _{OFF}		60		μs
	$V_{CC} = 5.0 \text{ V}; \text{ V}_{IN} = 3 \text{ V}$			60		
	$V_{CC} = 3.3 \text{ V}; \text{ V}_{IN} = 24 \text{ V}$			40		
	$V_{CC} = 5.0 \text{ V}; \text{ V}_{IN} = 24 \text{ V}$			40		
Power Good Turn-on Time	V_{CC} = 4.5 V; V_{IN} = 3 V	T _{PG,ON}	0.25	0.5	2.5	ms
	$V_{CC} = 5.0 \text{ V}; \text{ V}_{IN} = 3 \text{ V}$		0.25	0.5	2.5	
	$V_{CC} = 3.3 \text{ V}; \text{ V}_{IN} = 24 \text{ V}$		0.25	1.5	2.5	
	$V_{CC} = 5.0 \text{ V}; \text{ V}_{IN} = 24 \text{ V}$		0.25	1.5	2.5	1
Power Good Turn-off Time (Note 15)	V_{CC} = 4.5 V; V_{IN} = 3 V	T _{PG,OFF}			10	ns
	$V_{CC} = 5.0 \text{ V}; \text{ V}_{IN} = 3 \text{ V}$				10]
	V _{CC} = 3.3 V; V _{IN} = 24 V				10]
	$V_{CC} = 5.0 \text{ V}; \text{ V}_{IN} = 24 \text{ V}$				10]

13. See below figure for Test Circuit and Timing Diagram. 14. Tested with the following conditions: $V_{TERM} = V_{CC}$; $R_{PG} = 100 \text{ k}\Omega$; $R_L = 10 \Omega$; $C_L = 0.1 \mu$ F. 15. PG Turn–off time is very dependent on external pull up resistor and capacitive loading. Tested with 100 k Ω pull up to 3.3 V.



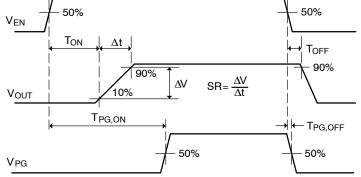
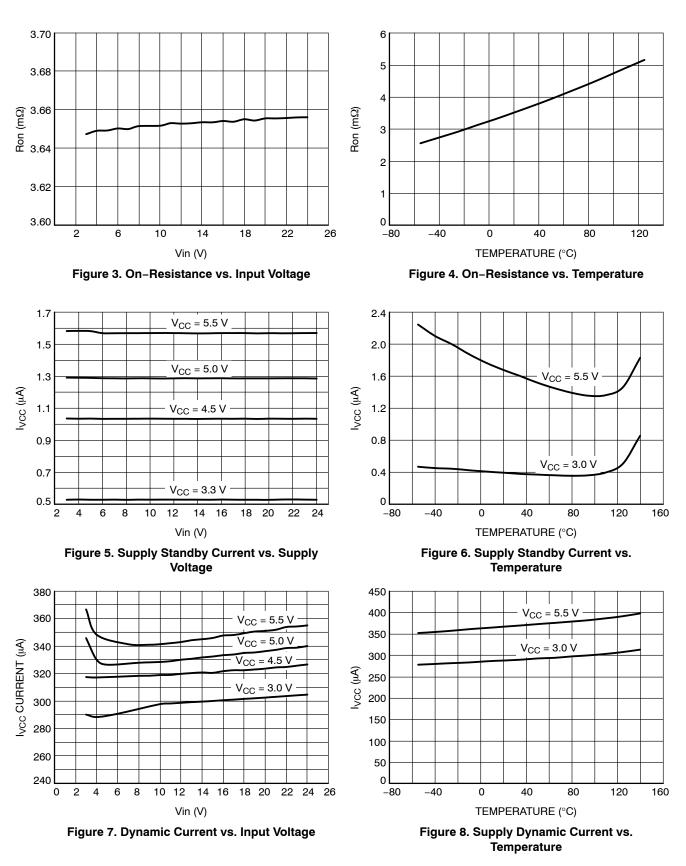
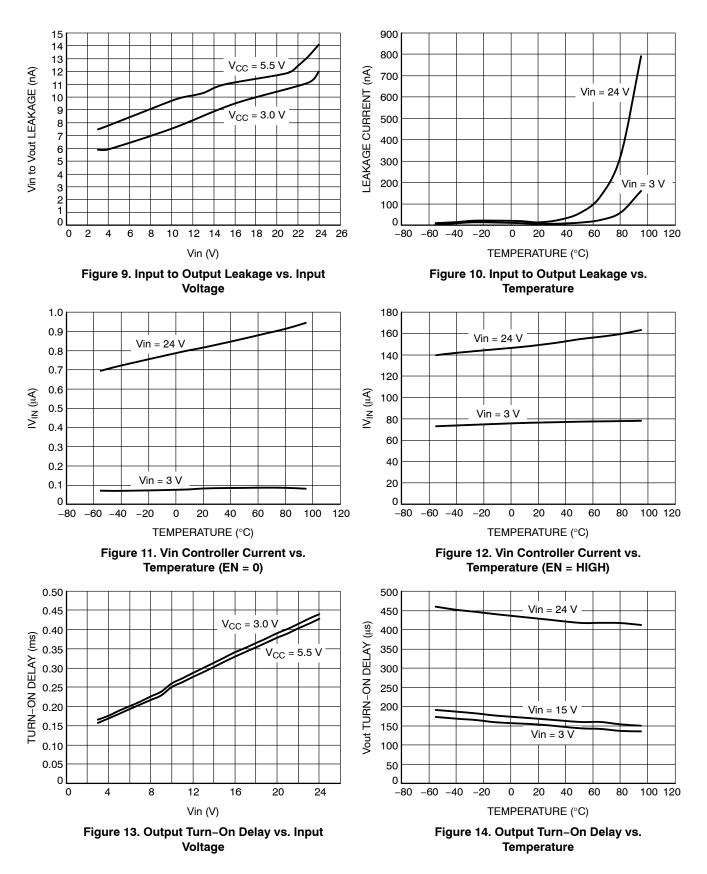
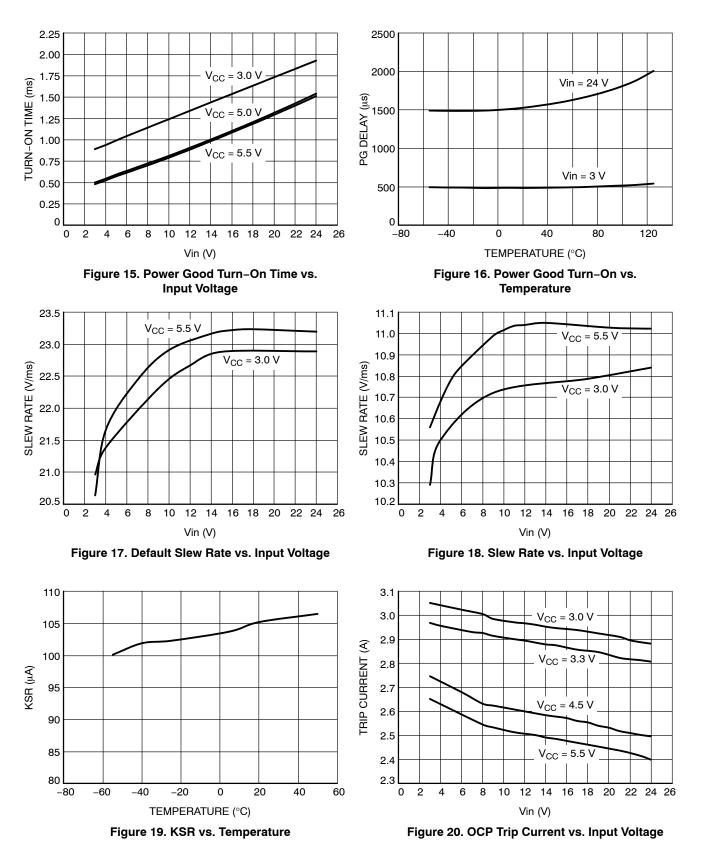
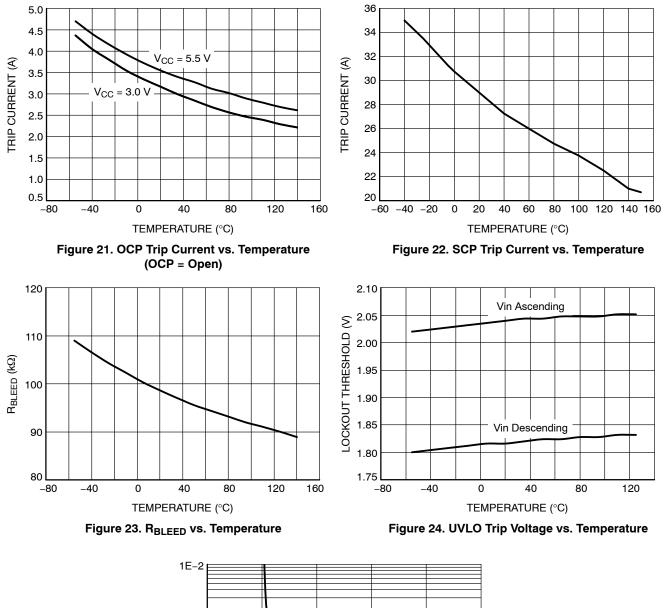


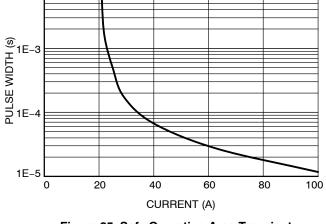
Figure 2. Switching Characteristics Test Circuit and Timing Diagram













APPLICATIONS INFORMATION

Enable Control

The NCP45770 part enables the MOSFET in an active-high configuration. When the EN pin is at a logic high level and the V_{CC} supply pin has an adequate voltage applied, the MOSFET will be enabled. When the EN pin is at a logic low level, the MOSFET will be disabled. An internal pull down resistor to ground on the EN pin ensures that the MOSFET will be disabled when not driven.

Short-Circuit Protection

The NCP45770 device is equipped with a short–circuit protection that helps protect the part and the system from a sudden high–current event, such as the output, V_{OUT} , being hard–shorted to ground.

Once active, the circuitry monitors the voltage difference between the V_{IN} pin and the V_{OUT} pin. When the difference is equal to the short–circuit protection threshold voltage, the MOSFET is turned off and the load bleed is activated. The part remains off and is latched in the Fault state until EN is toggled or V_{CC} supply voltage is cycled, at which point the MOSFET will be turned on in a controlled fashion with the normal output turn–on delay and slew rate. The short circuit protection feature protects the device from hard shorts (R_{SHORT} < 250 m Ω V_{OUT} to GND) for V_{IN} ≤ 18 V. Hard short circuit testing used a 10 m Ω short to ground for this scenario. The short circuit protection circuitry remains active regardless of the EN state to protect against enabling into a short circuit.

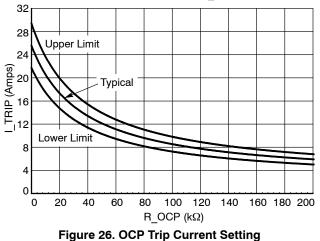
Over-Current Protection

The NCP45770 device is equipped with an over-current protection (OCP) that helps protect the part and the system from a high current event which exceeds the expected operational current (e.g., a soft short).

In the event that the current from the V_{IN} pin to the V_{OUT} pin exceeds the OCP threshold for longer than the blanking time, the MOSFET will shut down and the PG pin is driven low. Like the short-circuit protection, the part remains latched in the Fault state until EN is toggled or V_{CC} supply voltage is cycled, at which point the MOSFET will be turned on in a controlled fashion with the normal output turn-on delay and slew rate.

The over-current trip point is determined by the resistance between the OCP pin and ground. If no over-current protection is needed, then the OCP pin should be tied to GND; if the OCP protection is disabled in this way, the short-circuit protection will still remain active.

NCP45770 OCP Trip Current per R_OCP Resistance



Thermal Shutdown

The thermal shutdown of the NCP45770 device protects the part from internally or externally generated excessive temperatures. This circuitry is disabled when EN is not active to reduce standby current. When an over-temperature condition is detected, the MOSFET is turned off and the load bleed is activated.

The part comes out of thermal shutdown when the junction temperature decreases to a safe operating temperature as dictated by the thermal hysteresis. Upon exiting a thermal shutdown state, and if EN remains active, the MOSFET will be turned on in a controlled fashion with the normal output turn–on delay and slew rate.

Under Voltage Lockout

The under voltage lockout of the NCP45770 device turns the MOSFET off and activates the load bleed when the input voltage, $V_{\rm IN}$, drops below the under voltage lockout threshold. This circuitry is disabled when EN is not active to reduce standby current.

If the V_{IN} voltage rises above the under voltage lockout threshold, and EN remains active, the MOSFET will be turned on in a controlled fashion with the normal output turn–on delay and slew rate.

Power Good

The NCP45770 device has a power good output (PG) that can be used to indicate when the gate of the MOSFET is fully charged. The PG pin is an active-high, open-drain output that requires an external pull up resistor, RPG, greater than or equal to 100 k Ω to an external voltage source, VTERM, that is compatible with input levels of all devices connected to this pin, as shown in Figure 27.

The power good output can be used as the enable signal for other active-high devices in the system, as shown in Figure 27. This allows for guaranteed by design power sequencing and reduces the number of enable signals needed from the system controller. If the power good feature is not used in the application, the PG pin should be tied to GND.

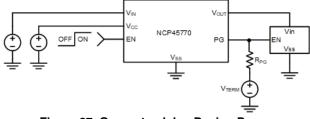


Figure 27. Guaranteed-by-Design Power Sequencing Example

Slew Rate Control

The NCP45770 device is equipped with controlled output slew rate which provides soft start functionality. This limits the inrush current caused by capacitor charging and enables these devices to be used in hot swapping applications.

The slew rate can be decreased with an external capacitor added between the SR pin and ground. With an external capacitor present, the slew rate can be determined by the following equation:

Slew Rate =
$$\frac{K_{SR}}{C_{SR}}$$
 [V/s] (eq. 1)

where K_{SR} is the specified slew rate control constant, found on page 3, and C_{SR} is the capacitor added between the SR pin and ground. Note that the slew rate of the device will always be the lower of the default slew rate and the adjusted slew rate. Therefore, if the C_{SR} is not large enough to decrease the slew rate more than the specified default value, the slew rate of the device will be the default value.

Capacitive Load

The peak in-rush current associated with the initial charging of the application load capacitance needs to stay below the specified I_{max} . C_L (capacitive load) should be less then C_{max} as defined by the following equation:

$$C_{max} = \frac{I_{max}}{SR_{typ}}$$
 (eq. 2)

Where I_{max} is the maximum load current, and SR_{typ} is the typical default slew rate when no external load capacitor is added to the SR pin.

OFF to ON Transition Energy Dissipation

The energy dissipation due to load current traveling from V_{IN} to V_{OUT} is very low during steady state operation due to the low R_{ON} . When the EN signal is asserted high, the load switch transitions from an OFF state to an ON state. During this time, the resistance from V_{IN} to V_{OUT} transitions from high impedance to R_{ON} , and additional energy is dissipated in the device for a short period of time. The worst case energy dissipated during the OFF to ON transition can be approximated by the following equation:

$$\mathsf{E} = 0.5 \cdot \mathsf{V}_{\mathsf{IN}} \cdot \left(\mathsf{I}_{\mathsf{INRUSH}} + 0.8 \cdot \mathsf{I}_{\mathsf{LOAD}}\right) \cdot \mathsf{dt} \quad (\mathsf{eq. 3})$$

Where V_{IN} is the voltage on the V_{IN} pin, I_{INRUSH} is the inrush current caused by capacitive loading on V_{OUT} , and dt is the time it takes V_{OUT} to rise from 0 V to V_{IN} . I_{INRUSH} can be calculated using the following equation:

$$I_{\text{INRUSH}} = \frac{dv}{dt} \cdot C_{\text{L}} \qquad (\text{eq. 4})$$

Where dv/dt is the programmed slew rate, and C_L is the capacitive loading on V_{OUT} . To prevent thermal lockout or damage to the device, the energy dissipated during the OFF to ON transition should be limited to E_{TRANS} listed in operating ranges table.

ecoSWITCH LAYOUT GUIDELINES

Electrical Layout Considerations

Correct physical PCB layout is important for proper low noise accurate operation of all ecoSWITCH products.

Power Planes: The ecoSWITCH is optimized for extremely low Ron resistance, however, improper PCB layout can substantially increase source to load series resistance by adding PCB board parasitic resistance. Solid connections to the V_{IN} and V_{OUT} pins of the ecoSWITCH to copper planes should be used to achieve low series resistance and good thermal dissipation. The ecoSWITCH requires ample heat dissipation for correct thermal lockout operation. The internal FET dissipates load condition dependent amounts of power in the milliseconds following the rising edge of enable, and providing good thermal conduction from the packaging to the board is critical. Direct coupling of VIN to VOUT should be avoided, as this will adversely affect slew rates. The number and location of pins for specific ecoSWITCH products may vary. This demonstrates large planes for both V_{IN} and V_{OUT}, while avoiding capacitive coupling between the two planes.

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			b	0.20	0.25	0.30
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			E	2.90	3.00	3,10
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